

engineering data service

5896

MECHANICAL DATA

	. T-3
Base E8-10, Subminiature Button Flexible	e Leads
Outline JET	TEC 3-1
Basing	
Cathode Coated Unipo	otential
Mounting Position	. Any
RATINGS¹ (Absolute Maximum)	
Impact Acceleration	450 G
Impact Acceleration	1000 G
Impact Acceleration	1000 G
Impact Acceleration	1000 G 2.5 G 220° C

ELECTRICAL DATA

HEATER CHARACTE	:KI	2110	CS.					
						Min.	Bogey	Max.
Heater Voltage ³						6.0	6.3	6.6 V
Heater Current .							300	m A

DIRECT INTERELECTRODE CAPACITANCES

Plate to Plate	Shielded⁴ 0.026	Unshielded 0.15 μμf Max.
(Each Section)	3.0	2.4 μμf
(Each Section)	4.2	4.0 μμf
RATINGS¹ * ¹ (Absolute Maximum) Plate Supply Voltage (Each Plate) Peak Inverse Plate Voltage ⁸ Steady State Peak Plate Current (Each Plate) Transient Peak Plate Current (Each Plate) . Output Current (Each Plate) Heater-Cathode Voltage ⁸ Heater Positive with Respect to Cathode Heater Negative with Respect to Cathode		165 Vac 460 v 60 ma 350 ma 10 mAdc 360 v 360 v
CHARACTERISTICS Tube Voltage Drop for Ib = 18 mAdc (Each Planck	late) .	4.5 Vdc
TVOIG 11 OPER 1TIGNI		

TYPICAL OPERATION

Full-Wave Rectifier—Capacitor Input to Filter		
Plate Voltage (Each Plate)		150 Vac
Filter Input Capacitance		8 μf
Load Resistor		11000 Ohms
Effective Plate Supply Impedance (Each Plate)		300 Ohms
Output Current		18 mAdc

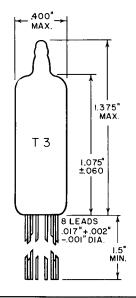
NOTES:

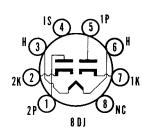
- 1. Limitations beyond which normal tube performance and tube life may be impaired.
- 2. If altitude rating is exceeded, reduction of instantaneous voltages (Ef excluded) may be required.
- 3. Tube life and reliability of performance are directly related to the degree of regulation of the heater voltage to its center-rated value of 6.3 volts.
- 4. External shield of 0.405 inch diameter connected to heater.
- 5. Diode input; plate to cathode, heater, internal shield and external shield (other section grounded).
- 6. Cathode to heater, plate, internal shield and external shield (other section grounded)
- 7. Values shown are as registered with RETMA.
- 8. The maximum voltage appearing between any pair of leads shall be no greater than the maximum peak inverse plate voltage.

QUICK REFERENCE DATA

The Premium Subminiature Type 5896 is a high perveance double diode having separate cathode connections for each section. Electrically this type is similar to the 6AL5 and is intended for a variety of detector applications at UHF as well as low frequencies.

The 5896 is manufactured and inspected to meet the applicable MIL-E-1 specification for reliability and is designed to provide dependable service under conditions of severe shock, vibration, high temperature and high altitude.





SYLVANIA ELECTRIC PRODUCTS INC.

RADIO TUBE DIVISION EMPORIUM, PA.

Prepared and Released By The
TECHNICAL PUBLICATIONS SECTION
EMPORIUM, PENNSYLVANIA

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ACCEPTANCE CRITERIA

Test Conditions

Heater Voltage	6.3 V	Load Resistance	000 Ohms
Plate Supply Voltage Per Plate	165 Vac	Load Capacitance	8 μf
Heater-Cathode Voltage	0 V		

For the purposes of inspection, use applicable reliable paragraphs of MIL-E-1 and Inspection Instructions for Electron Tubes.

MIL-E-I		AQL						
Ref.	Test	(%)	Min.	LAL	Bogey	UAL	Max.	Units
Measureme	ents Acceptance Tests, Part I, Note I							
4.1.1.7 4.10.8	(Method A) Heater Current: ALD = 24		_	288	300	312	_	mA
4.10.8	Heater Current:	0.65	280	_	_		320	mA
4.10.15	Heater-Cathode Leakage: Note 2 Ehk = +360 Vdc Ehk = -360 Vdc	0.65	_ 		_ _ _	_ _ _	 40 40	μAdc μAdc
4.10.13	Operation: Note 5 Io	0.65	16	_	_	_	_	mAdc
4.7.5	Continuity and Shorts (Inoperatives):	0.4		_	_	_	_	
4.9.1	Mechanical: Envelope (8-1)	_	_	_	_	_	_	
Measureme	ents Acceptance Tests, Part 2							
4.8.2	Insulation of Electrodes: Note 2 p-all	2.5	100	_	_	_		Meg
4.10.1.1	Emission: Note 2 Is Eb = 10 Vdc	2.5	30		_	_	_	mAdc
4.10.4.1	Plate Current: Note 2 Ebb = 0 V; Rp = 40,000 Ohms	2.5	5.0	_	-	-	25	μAdc
4.10.4.1	Plate Current Difference Between Sections:	2.5	_		_		5.0	μAdc
4.10.14	Capacitance: 0.405 In. Dia. Shield. Clp to 2p. Clp to h+1k+sd. C2p to h+2k+sd. C1k to h+1p+sd. C2k to h+2p+sd.	6.5 — — — —	2.5 2.5 3.5 3.5	_ _ _ _ _			0.026 3.5 3.5 4.9 4.9	μμf μμf μμf μμf μμf μμf
4.9.12.1	Low Pressure Voltage Breakdown: Pressure = 55 ±5 mm Hg.; Voltage = 330 Vac	6.5	_	_	_	_	_ ;	
4.9.20.3	Vibration (1): No Voltages; Post Shock and Fatigue Test End Points Apply	10.0		_	_	_	_	
Degradatio	n Rate Acceptance Tests, Note 3							
4.9.5.3	Subminiature Lead Fatigue:	2.5	4	_	_	_	_	arcs
4.9.20.5	Shock: Hammer Angle = 30°; Ehk = +100 Vdc	20		_	-	_	-	
4.9.20.6	Fatigue: G = 2.5; Fixed Frequency; F = 25 min., 60 max	6.5	_	_	_	_	_	
	Post Shock and Fatigue Test End Points: Heater-Cathode Leakage Ehk = +360 Vdc. Ehk = -360 Vdc. Operation Io.	_ 	_ 14	 - -	<u>-</u>	-	80 80 —	μAdc μAdc mAdc
4.9.6.3	Glass Strain:	6.5		_	_	_	_	

ACCEPTANCE CRITERIA (Continued)

			Allowable per Char	Lin			
MIL-E-I Ref.	Test		lst Sample	Combined Samples	Min.	Max.	Units
Acceptanc	e Life Tests, Note 3						
4.11.7	Heater Cycling Life Test: Ef = 7.0 V; 1 min. on; 4 min. off; Ehk = 140 Vac; E1b = E2b = O V	2.5			_	_	
4.11.3.1	Stability Life Test: (1 hour) Note 6 TA = Room	1.0	_	_		_	
4.11.4	Stability Life Test End Points: Change in Operation of Individual Tubes \[\sum_{\text{t}}^{\text{Io}} \cdots \sum_{\text{t}}^{\text{Io}} \sum_{\text{t}}^{\text{Io}} \cdots \sum_{\text{t}}^{\text{Io}} \cdots \sum_{\text{t}}^{\text{Io}} \cdots \sum_{\text{t}}^{\text{Io}} \sum_{\text{t}}^{\text{Io}} \cdots \sum_{\text{t}}^{\text{Io}} \sum_{\tex	_		_		10.0	%
4.11.3.1 4.11.3.1.1	Survival Rate Life Test: (100 Hours) Stability Life Test Conditions or Equivalent; TA = Room	_		_	_	_	
	Survival Rate Life Test End Points: Continuity and Shorts (Inoperatives) Operation Io	0.65	_ _	<u>-</u>	 14.0	<u>-</u>	mAdc
4.11.5 4.11.3.1 4.11.3.1	Intermittent Life Test: Note 4 Stability Life Test Conditions; T Envelope = +220°C min.; 1000 Hour Requirements Do Not Apply	-	_				
4.11.4	Intermittent Life Test End Points: (500 Hours) Inoperatives. Heater Current. Operation Io. Change in Operation of Individual	 	1 2 1	3 5 3	 276 14	 328 	mA mAdc
	Tubes I o	-	1	3	_	15	%
	Heater-Cathode Leakage. Ehk = +360 Vdc. Ehk = -360 Vdc. Insulation of Electrodes. p-all. Total Defectives.		2 - 2 - 4	5 5 8		80 80 — —	μAdc μAdc Meg

ACCEPTANCE CRITERIA NOTES:

- 1: The AQL for the combined defectives for attributes in Measurements Acceptance Tests, Part 1, excluding inoperatives and mechanical shall be one (1) percent. A tube having one (1) or more defects shall be counted as one (1) defective.
- 2: Test each section separately.
- 3: Tubes subjected to the following destructive tests are not to be accepted under this specification.
 - 4.9.5.3 Subminiature lead fatigue
 - 4.9.20.5 Shock
 - 4.9.20.6 Fatigue
 - 4.11.7 Heater cycling life test
 - 4.11.5 Intermittent life test

- 4: Envelope temperature is defined as the highest temperature indicated when using a thermocouple of \$40 BS or smaller diameter elements welded to a ring of 0.025 inch diameter phosphor bronze placed in contact with the envelope. Envelope temperature requirement will be satisfied if a tube, having bogey Ib (±5%) under normal test conditions, is determined to operate at maximum specified temperature at any position on the life test rack.
- 5: In a full-wave circuit, adjust Zp/p so that a bogey tube gives Io = 18 mAdc. A bogey tube has a tube drop Etd = 10 Vdc at Is = 50 mAdc per plate. Ehk = Eo \pm 117 Vac.
- 6: In a full-wave life test circuit, the values specified for RL and CL may be considered approximate and shall be adjusted initially to give not less than Io = 18 mAdc and ib = 50 ma with a bogey tube. Ehk = Eo +117 Vac.

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APPLICATION DATA

The Premium Subminiature Type 5896 is a high perveance subminiature double diode. Separate cathode connection permit independent operation of each section. Electrically, this type is very similar to the miniature Type 6AL5. It is particularly useful in a variety of detector application including discriminators or ratio detectors at uhf as well as low frequencies.

The resonant frequency of each diode section is greater than 900 megacycles, making the type applicable to use in automatic frequency control discriminator circuits in the uhf region. The line length in push-pull applications of this nature is plotted against frequency in Figure 1.

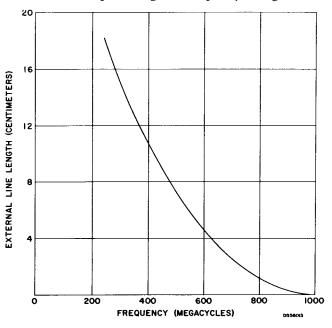


Figure 1 Approximate resonant-line length vs frequency

In critical detector applications, a reduction in hum output and contact potential voltage may be realized by lowering the operating heater voltage. Such a reduction will, however, result in a plate characteristic curve which departs from that obtained with rated heater voltage, Figure 2. With practical values of reduced heater voltage, hum output may be lowered by as much as 60% and contact potential by 20 to 30%. Operation under these conditions is satisfactory, providing the current requirements are consistent with values normally encountered in low level detection. An alternative method of lowering hum output and contact potential is to bias the heater with respect to the cathode.

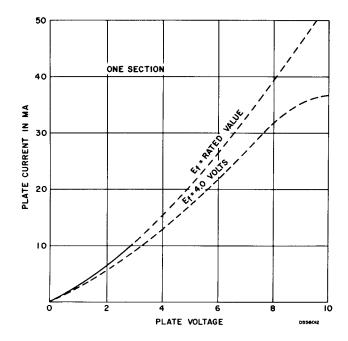


Figure 2 Approximate Plate Characteristics at reduced heater voltage

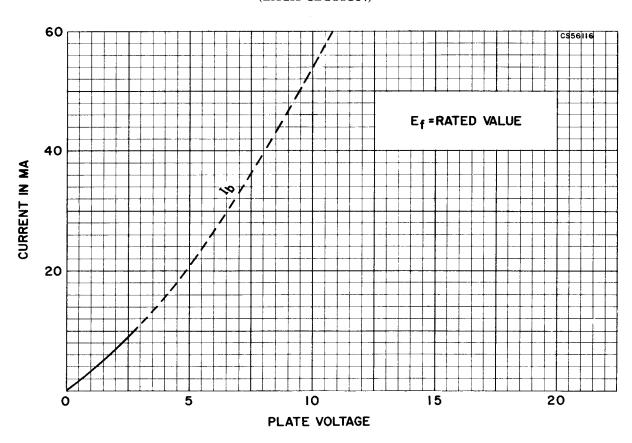
The 5896 is also useful in clamping and gating applications.

The 5896 is intended for operation under conditions of severe shock, vibration, high altitude and high temperature and is manufactured and inspected to meet the applicable MIL-E-1 specification for reliability.

Life expectancy is described by the life tests, specified on the attached pages and/or individual MIL-E-1 specifications. The actual life expectancy of the tubes in an operating circuit is affected by both the operating and environmental conditions involved. Likewise, the life tests specified indicate performance under certain operating criteria to a set of specified end points. Performance at conditions other than those specified can usually be estimated only roughly as giving better or poorer life expectancy. For further discussion of life expectancy, reference should be made to the frontal section of this manual.

When operated under conditions common to on-off control applications the tube exhibits freedom from the development of interface resistance. The heater-cathode construction is designed to withstand intermittent operation.

AVERAGE PLATE CHARACTERISTICS (EACH SECTION)



AVERAGE CHARACTERISTICS (EACH SECTION)

